

STD6NF10 STU6NF10

N-channel 100 V, 0.22 Ω 6 A, DPAK, IPAK low gate charge STripFET™ Power MOSFET

Features

Туре	V_{DSS}	R _{DS(on)} max	I _D
STD6NF10	100 V	< 0.250 Ω	6 A
STU6NF10	100 V	< 0.250 Ω	6 A

- Exceptional dv/dt capability
- 100% avalanche tested

Application

Switching applications

Description

This Power MOSFET series realized with STMicroelectronics unique STripFET process has specifically been designed to minimize input capacitance and gate charge. It is therefore suitable as primary switch in advanced highefficiency, high-frequency isolated DC-DC converters for telecom and computer applications. It is also intended for any applications with low gate drive requirements.

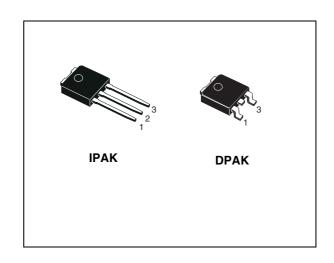


Figure 1. Internal schematic diagram

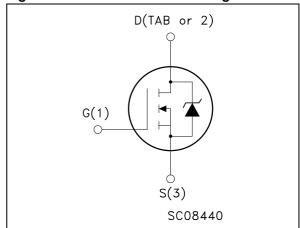


Table 1. Device summary

Order codes	rder codes Marking Package		Packaging
STD6NF10T4	D6NF10	DPAK	Tape and reel
STU6NF10	6NF10	IPAK	Tube

Contents

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STD6NF10, STU6NF10 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit	
V _{DS}	Drain-source voltage (V _{GS} = 0)	100	V	
V _{GS}	Gate- source voltage	± 20	V	
I _D	Drain current (continuous) at T _C = 25 °C	6	Α	
I _D	Drain current (continuous) at T _C = 100 °C	4	Α	
I _{DM} ⁽¹⁾	Drain current (pulsed)	24	Α	
P _{tot}	Total dissipation at T _C = 25 °C	30	W	
	Derating factor 0.2		W/°C	
dv/dt (2)	Peak diode recovery voltage slope 40		V/ns	
E _{AS} (3)	Single pulse avalanche energy	200	mJ	
T _{stg}	Storage temperature	65 to 175	°C	
Tj	Max. operating junction temperature	-65 to 175 °C		

^{1.} Pulse width limited by safe operating area.

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	5	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	100	°C/W
T _J	Maximum lead temperature for soldering purpose	300	°C

 $^{2. \}quad I_{SD} \ \leq \ 6 \ A, \ di/dt \ \leq 300 \ A/\mu s, \ V_{DD} \ \leq \ V_{(BR)DSS}, \ Tj \ \leq T_{JMAX}$

^{3.} Starting $T_j = 25$ °C, $I_D = 3$ A, $V_{DD} = 50$ V

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 250 \ \mu\text{A}, \ V_{GS} = 0$	100			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = max rating V_{DS} =max rating, T_{C} = 125 °C			1 10	μ Α μ Α
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 20 V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2		4	V
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}$		0.22	0.25	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	$V_{DS} = I_{D(on)} X$ $R_{DS(on)max}, I_{D} = 3A$		34		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz,}$ $V_{GS} = 0$		280 45 20		pF pF pF
$\begin{array}{c} t_{d(on)} \\ t_{r} \\ t_{d(off)} \\ t_{f} \end{array}$	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 50 \text{ V}, I_{D} = 3 \text{ A}$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 13</i>)		6 10 20 3		ns ns ns
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 80 \text{ V}, I_D = 6 \text{ A},$ $V_{GS} = 10 \text{ V}, R_G = 4.7 \Omega$ (see Figure 14)		10 2.5 4	14	nC nC nC

^{1.} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%.

Table 6. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current Source-drain current (pulsed)				6 24	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 6 A, V _{GS} = 0			1.3	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 6 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s,}$ $V_{DD} = 10 \text{ V, T}_j = 150 ^{\circ}\text{C}$ (see <i>Figure 15</i>)		70 175 5		ns nC A

^{1.} Pulse width limited by safe operating area.

^{2.} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

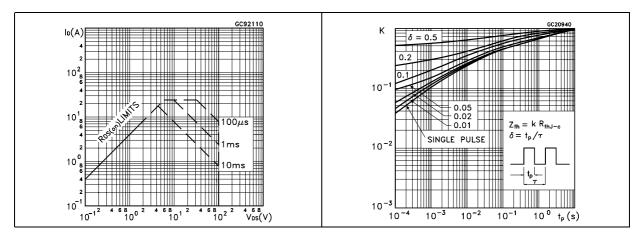


Figure 4. Output characteristics

Figure 5. Transfer characteristics

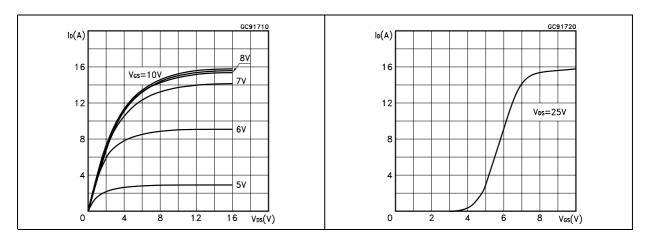
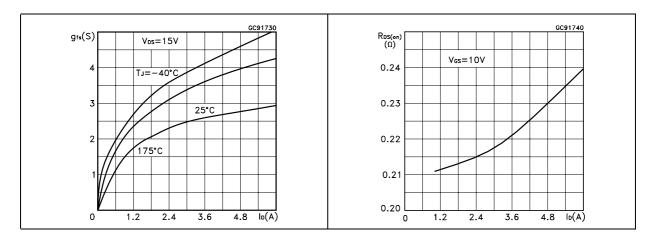


Figure 6. Transconductance

Figure 7. Static drain-source on resistance



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Figure 8. Gate charge vs. gate-source voltage Figure 9. Capacitance variations

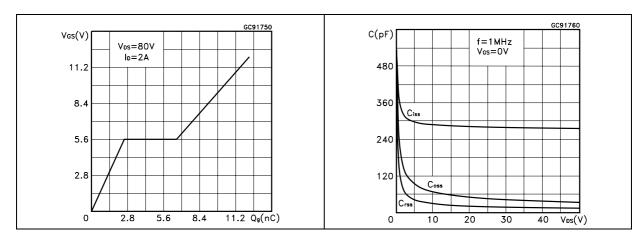


Figure 10. Normalized gate threshold voltage Figure vs. temperature

Figure 11. Normalized on resistance vs. temperature

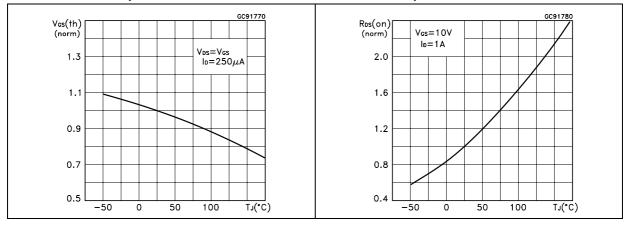
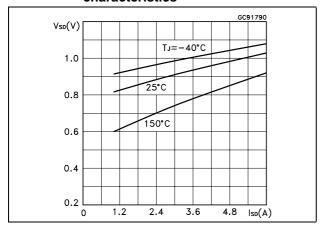


Figure 12. Source-drain diode forward characteristics



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3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

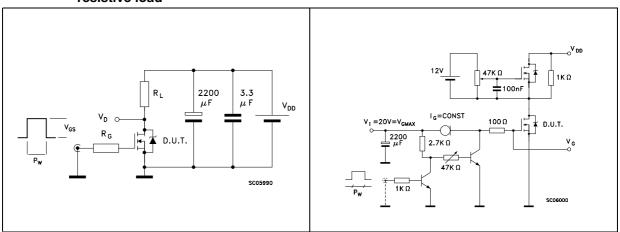


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped Inductive load test circuit

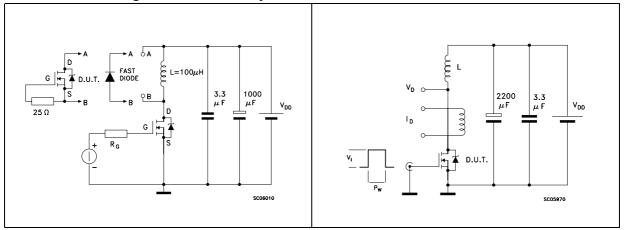
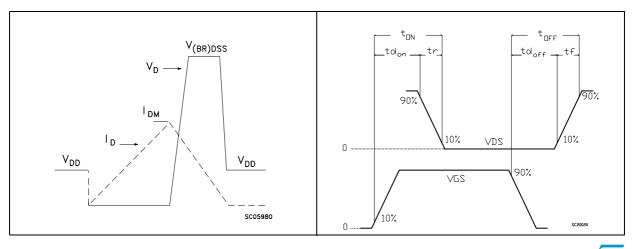


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



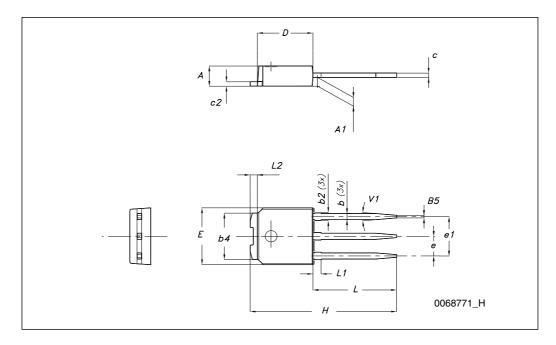
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

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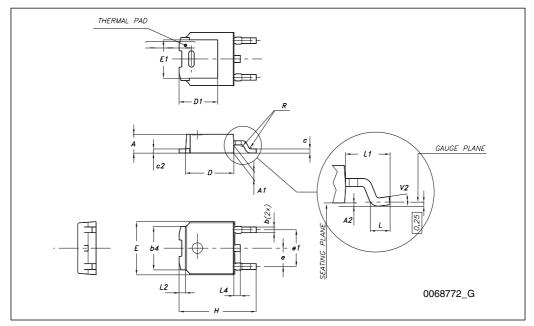
TO-251 (IPAK) mechanical data

DIM		mm.	
DIM.	min.	typ	max.
Α	2.20		2.40
A1	0.90		1.10
b	0.64		0.90
b2			0.95
b4	5.20		5.40
С	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
E	6.40		6.60
е		2.28	
e1	4.40		4.60
Н		16.10	
L	9.00		9.40
(L1)	0.80		1.20
L2		0.80	
V1		10 °	



TO-252 (DPAK) mechanical data

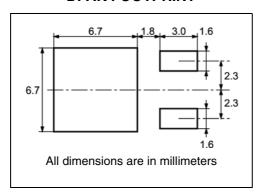
	1	mm	
DIM.		mm.	_
	min.	typ	max.
Α	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
С	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1		5.10	
Е	6.40		6.60
E1		4.70	
е		2.28	
e1	4.40		4.60
Н	9.35		10.10
L	1		
L1		2.80	
L2		0.80	
L4	0.60		1
R		0.20	
V2	0 °		8 °



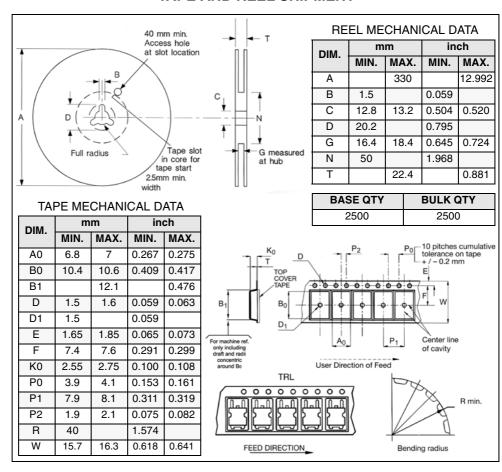
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5 Packing mechanical data

DPAK FOOTPRINT



TAPE AND REEL SHIPMENT



STD6NF10, STU6NF10 Revision history

6 Revision history

Table 7. Document revision history

Date	Revision	Changes
21-Jun-2004	3	Complete version
20-Jul-2006	4	New template, no content change
16-Sep-2008	5	Corrected part number: STU6NF10
19-Nov-2008	6	Marking label in <i>Table 1</i> for the device in IPAK has been updated. I _{GSS} value in <i>Table 4</i> has been updated

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